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PATENT

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application of : Customer Number: 20277

Shigeo MURAKAMI : Confirmation Number: 7075

Application No.: 10/615,294 : Group Art Unit: 2625

Filed: July 09, 2003 : Examiner: Not Yet Assigned

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APPARATUS

INFORMATION DISCLOSURE STATEMENT

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Dear Sir:

In accordance with the provisions of 37 C.F.R. 1.56, 1.97 and 1.98, the attention of the Patent and Trademark Office is hereby directed to the documents listed on the attached form PTO-1449. It is respectfully requested that the documents be expressly considered during the prosecution of this application, and that the documents be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

This Information Disclosure Statement is being filed before the mailing date of a first Office Action on the merits. No certification or fee is required.

Each reference was first cited in a corresponding European Search Report and its relevance is discussed therein. A copy of the European Search Report is attached for the Examiner's information.

10/615,294

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Respectfully submitted,

McDERMOTT WILL & EMERY LLP

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SHEET 1 OF 1

MATION DISCLOSURE ATTY. DOCKET NO. SERIAL NO. 058604-0029 10/615,294 CITATION IN AN **APPLICATION APPLICANT** Shigeo MURAKAMI FILING DATE **GROUP** (PTO-1449) July 09, 2003 2625 U.S. PATENT DOCUMENTS **EXAMINER'S** CITE Document Number Publication Date Name of Patentee or Applicant of Cited Pages, Columns, Lines, Where MM-DD-YYYY Relevant Passages or Relevant INITIALS Document Number-Kind Code2 (# known) Figures Appear us 06-30-1998 5,774,635 KUUSISTO et al. /V.H./ ÜS 2001/0010191 A1 08-02-2001 STEINBACHER /V.H.US 5,450,165 09-12-1995 HENDERSON NHIÜŚ US US FOREIGN PATENT DOCUMENTS **EXAMINER'S** Foreign Patent Document Publication Date Name of Patentee or Applicant Pages, Columns, Translation INITIALS of Cited Document Lines Where CITE Country Codes-Number 4-Kind MM-DD-YYYY Yes Νo Codes (if known) Relevant Figures Appear EP 0 803 356 A2 10-29-1997 **ADVANCED VISION** X /V.H./TECHNOLOGY (A.V.T.) LTD. GRETAG EP 0 142 470 A1 05-22-1985 X /V.H./ **AKTIENGESELLSCHAFT** OTHER ART (Including Author, Title, Date, Pertinent Pages, Etc.) Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, **EXAMINER'S** INITIALS journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where CITE NO. European Search Report issued in corresponding European Patent Application No. 03015450.4 -/V.H./1228, dated January 30, 2007 **EXAMINER** DATE CONSIDERED 02/01/2010 /Vu Hang/

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